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OPEN Author Correction: Electrochemical **Performance of Supercapacitor** with Stacked Copper Foils Coated with Graphene Nanoplatelets

S. L. Chiam¹, H. N. Lim^{1,2}, S. M. Hafiz², A. Pandikumar³ & N. M. Huang⁴

Correction to: Scientific Reports https://doi.org/10.1038/s41598-018-21572-x, published online 15 February 2018

This Article contains a typographical error in the Results and Discussion section where,

"This value is 213 times higher compared to graphitic powder (2.78 m²/g) 6, indicating that graphite was significantly exfoliated into few graphitic layers (2630/591 \approx 4) by thermal exfoliation."

should read:

"This value is 213 times higher compared to graphitic powder $(2.78 \text{ m}^2/\text{g})^6$, indicating that graphite was significantly exfoliated into few graphitic layers ($2630/591 \approx 4$) by thermal exfoliation."

In addition, this Article contains an error in the order of the Figures. Figures 2 and 3 were published as Figures 3 and 2 respectively. The correct Figures 2 and 3 appear below as Figures 1 and 2 respectively.

¹Department of Chemistry, Faculty of Science, Universiti Putra Malaysia, 43400 UPM, Serdang, Selangor, Malaysia. ²Materials Synthesis and Characterization Laboratory, Institute of Advanced Technology, Universiti Putra Malaysia, 43400 UPM, Serdang, Selangor, Malaysia. ³Electrochemical Materials Science and Functional Materials Division, CSIR-Central Electrochemical Research Institute, Karaikudi, 630003, India. ⁴New Energy Science & Engineering Programme, University of Xiamen Malaysia, Jalan SunSuria, Bandar SunSuria, 43900, Sepang, Selangor Darul Ehsan, Malaysia. Correspondence and requests for materials should be addressed to H.N.L. (email: janetlimhn@qmail.com) or S.M.H. (email: syedhafiz27@gmail.com) or N.M.H. (email: huangnayming@xmu.edu.my)

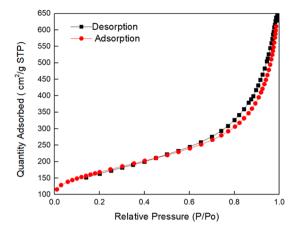


Figure 1. Nitrogen adsorption and desorption isotherms for GNPs.

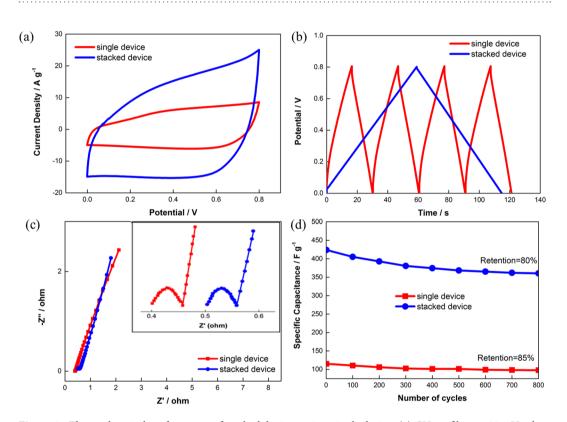


Figure 2. Electrochemical performance of stacked device against single device: (a) CV profiles at 100 mV s^{-1} , (b) GCD profiles at 3 A g^{-1} , (c) Nyquist plot with inset showing magnified version at low-frequency region, and (d) performance durability test at 3 A g^{-1} .

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